

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) <div style="border: 1px solid black; border-radius: 50%; padding: 5px; display: inline-block; transform: rotate(-45deg); transform-origin: center;"> OIPE AUG 06 2003 PATENT & TRADEMARK OFFICE </div>				ATTY DOCKET NO. 03500.016142.		APPLICATION NO. 10/058,749	
APPLICANT HITOSHI WATANABE ET AL.				FILING DATE January 30, 2002		GROUP 2176	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JG		5,847,836	12/08/98	Suzuki	358	296	
JG		4,740,796	04/26/88	Endo et al.	346	1.1	
JG		4,723,129	02/02/88	Endo et al.	346	1.1	
JG		4,558,333	12/10/85	Sugitani et al.	346	140 R	
JG		4,463,359	07/31/84	Ayata et al.	346	1.1	
JG		4,459,600	07/10/84	Sato et al.	346	140 R	
JG		4,345,262	08/17/82	Shirato et al.	346	140 R	
JG		4,313,124	01/26/82	Hara	346	140 R	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
JG		10-243327 A	09/11/98	JAPAN			Abstract & EP-0-862-313
JG		9-65182 A	03/07/97	JAPAN			Abstract & US 5,847,836
JG		59-123670 A	07/17/84	JAPAN			Abstract
JG		59-138461 A	08/08/84	JAPAN			Abstract
JG		0 862 313 A2	09/02/98	EPO	H04N	1/00	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
				RECEIVED			
				AUG 07 2003			
				Technology Center 2100			
EXAMINER <u>/Jerome Grant II/</u>				DATE CONSIDERED <u>07/30/2006</u>			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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